# LINEAR SYSTEMS

### Twenty-Five Years Of Quality Through Innovation

# LSK489

### LOW NOISE LOW CAPACITANCE MONOLITHIC DUAL N-CHANNEL JFET AMPLIFIER

FEATURES	
ULTRA LOW NOISE	$e_n = 1.8 nV/\sqrt{Hz}$
LOW INPUT CAPACITANCE	Ciss = 4pF

#### Features

- Reduced Noise due
  to process improvement
- Monolithic Design
- High slew rate
- Low offset/drift voltage
- Low gate leakage lgss & lg
- High CMRR 102 dB

#### Benefits

- Tight differential voltage match vs. current
- Improved op amp speed settling time
  accuracy
- Minimum Input Error trimming error voltage
- Lower intermodulation distortion

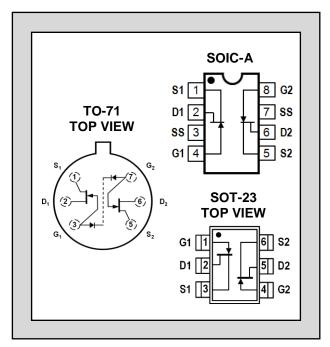
### Applications

- Wide band differential Amps
- High speed temperature compensated single ended input amplifier amps
- High speed comparators
- Impedance Converters

### Description

The LSK 489 series of high performance monolithic dual JFETs features extremely low noise, tight offset voltage and low drift over temperature specifications, and is targeted for use in a wide range or precision instrumentation applications. This series has a wide selection of offset and drift specifications. The SST series SO-8 package provided ease of manufacturing and the symmetrical pinout prevents improper orientation. The SO-8 package is available with tape and reel options for compatibility with automatic assembly methods. (See packaging data)

ABSOLUTE MAXIMUM RATINGS <sup>1</sup> @ 25 °C (unless otherwise stated)					
Maximum Temperatures					
Storage Temperature	-55 to +150°C				
Junction Operating Temperature	-55 to +150°C				
Maximum Power Dissipation, TA = 25°C					
Continuous Power Dissipation, per side <sup>4</sup>	300mW				
Power Dissipation, total <sup>5</sup>	500mW				
Maximum Currents					
Gate Forward Current	$I_{G(F)} = 10 \text{mA}$				
Maximum Voltages					
Gate to Source	$V_{GSO} = 60V$				
Gate to Drain	$V_{GDO} = 60V$				



\* For equivalent single version, see LSK189

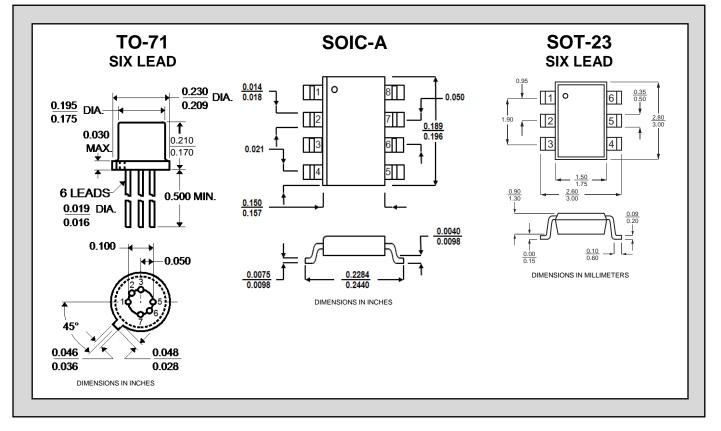
### MATCHING CHARACTERISTICS @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
$\left V_{GS1}-V_{GS2}\right $	Differential Gate to Source Cutoff Voltage			20	mV	$V_{DS} = 10V, I_D = 1mA$
	Gate to Source Saturation Current Ratio	0.9		1.0		$V_{DS} = 10V, V_{GS} = 0V$
CMRR	COMMON MODE REJECTION RATIO -20 log   ΔV <sub>GS1-2</sub> /ΔV <sub>DS</sub>	95	102		dB	$V_{DS}$ = 10V to 20V, $I_D$ = 200 $\mu$ A

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
en	Noise Voltage		1.8	2.0	nV/√Hz	$V_{DS} = 15V, I_D = 2.0mA, f = 1kHz, NBW = 1Hz$
en	Noise Voltage		2.8	3.5	nV/√Hz	$V_{DS} = 15V, I_D = 2.0 \text{mA}, f = 10 \text{Hz},$ NBW = 1Hz
Ciss	Common Source Input Capacitance		4	8	pF	
Crss	Common Source Reverse Transfer Capacitance			3	pF	$V_{DS} = 15V, I_D = 500\mu A, f = 1MHz$

### ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise stated)

SYMBOL	CHARACTERISTIC	MIN	TYP	MAX	UNITS	CONDITIONS
BV <sub>GSS</sub>	Gate to Source Breakdown Voltage	-60			V	$V_{DS} = 0, I_D = -1nA$
V(BR)G1 - G2	Gate to Gate Breakdown Voltage	±30	±45		V	I <sub>G</sub> = ±1µA, I <sub>D</sub> =I <sub>S</sub> =0 A (Open Circuit)
VGS(OFF)	Gate to Source Pinch-off Voltage	-1.5		-3.5	V	$V_{DS} = 15V, I_D = 1nA$
V <sub>GS</sub>	Gate to Source Operating Voltage	-0.5		-3.5	V	$V_{DS} = 15V, I_D = 500\mu A$
I <sub>DSS<sup>2</sup></sub>	Drain to Source Saturation Current	2.5	5	15	mA	$V_{DG} = 15V, V_{GS} = 0$
	Cata Operating Current		-2	-25	pА	$V_{DG} = 15V, I_D = 200\mu A$
l <sub>G</sub>	Gate Operating Current		-0.8	-10	nA	T <sub>A</sub> = 125°C
lgss	Gate to Source Leakage Current			-100	pА	$V_{DG} = -15V, V_{DS} = 0$
G <sub>fs</sub>	Full Conductance Transconductance	1500			μS	$V_{DG} = 15V, V_{GS} = 0, f = 1kHz$
Gfs	Transconductance	1000	1500		μS	$V_{DG} = 15V, I_D = 500\mu A$
Gos	Full Output Conductance			40	μS	$V_{DG} = 15V, V_{GS} = 0$
Gos	Output Conductance		1.8	2.7	μS	$V_{DG} = 15V, I_D = 200\mu A$
NF	Noise Figure			0.5	dB	$V_{DS} = 15V, V_{GS} = 0, R_G = 10M\Omega, f = 100Hz, NBW = 6Hz$

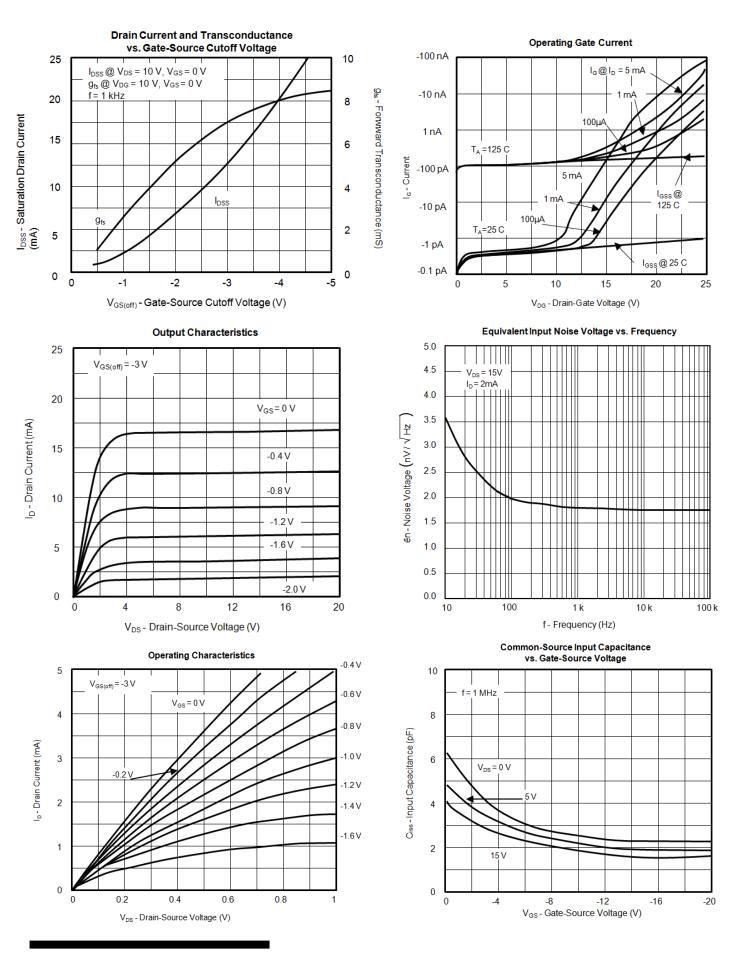


### NOTES

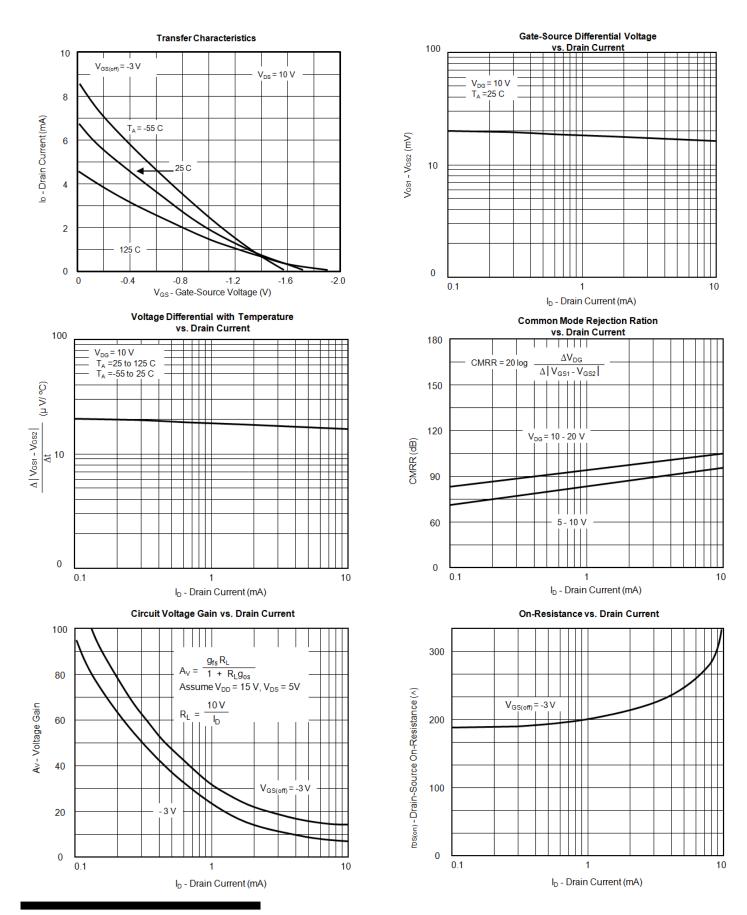
- 1. Absolute maximum ratings are limiting values above which serviceability may be impaired.
- 2. Pulse width  $\leq 2_{ms}$ .
- 3. All MIN/TYP/MAX Limits are absolute values. Negative signs indicate electrical polarity only.
- 4. Derate 2.4 mW/°C above 25°C.
- 5. Derate 4 mW/°C above 25°C.

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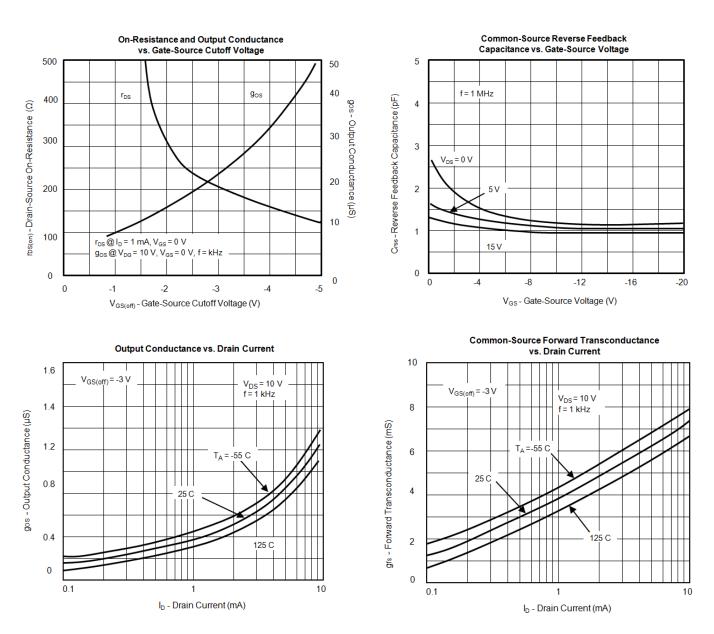
# **Typical Characteristics**



# **Typical Characteristics (Cont'd)**



# **Typical Characteristics (Cont'd)**



Linear Integrated Systems (LIS) is a 25-year-old, third-generation precision semiconductor company providing high-quality discrete components. Expertise brought to LIS is based on processes and products developed at Amelco, Union Carbide, Intersil and Micro Power Systems by company President John H. Hall. Hall, a protégé of Silicon Valley legend Dr. Jean Hoerni, was the director of IC Development at Union Carbide, Co-Founder and Vice President of R&D at Intersil, and Founder/President of Micro Power Systems.